Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination		
10/711,534	YEH, JIH-CHEN		
Examiner	Art Unit		
Stephen J. Kalafut	1745		

SEARCHED					
Class	Subclass	Date	Examiner		
429	96, 97, 99, 100, 174	7/16/2007	SJK		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
eDAN Inventor Name Search	7/16/2007	SJK		
EAST: USPAT, USPGPUB, USOCR, DERWENT, JPAB, EPAB	- 7/16/2007	SJK		
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